

## Notic of R ferences Cited

Application/Control No.	Applicant(s)/Pater	nt Under
09/890,025	Reexamination HEPWORTH, PAUL STEABBEN	
Examiner	Art Unit	
Stephen Choi	3724	Page 1 of 1

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<sup>\*</sup>A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.